Docket No.: GR 99 P 4044 CIP

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Jörg-Reinhart Kropp

Confirmation No.: 8607

CIP of

Applic. No. :

09/520,279, filed March 6, 2000

CIP filed

March 26, 2004

Title

**Transmission Configuration** 

Examiner

Reza Sedighian

Group Art Unit: 2633

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are cited herewith:

German Published, Non-Prosecuted Patent Application DE 196 45 295 A1 (Kropp), dated April 30, 1998, which corresponds with U.S. Patent No. 6,044,188;

P.L. Gourley et al.: "Coherent beams from high efficiency two-dimensional surface-emitting semiconductor laser arrays", Appl. Phys. Lett., Vol. 58, No. 9, March 4, 1991, pp. 890-892.

The above-mentioned references were cited in an Information Disclosure Statement submitted on August 12, 2002, in parent application No. 09/520,279.

German Published, Non-Prosecuted Patent Application DE 198 38 571 A1 (Tanaka et al.), dated March 4, 1999, which corresponds with U.S. Patent No. 6,353,491 B1;

German Examination Report dated October 18, 1999.

The above-mentioned references were cited in an Information Disclosure Statement submitted on December 4, 2002, in parent application No. 09/520,279.

German Patent DE 29 30 317 C2 (Kalmbach), dated February 19, 1981;

German Published Non-Prosecuted Patent Application DE 31 12 167 A1 (Westermann), dated October 14, 1982;

German Published Non-Prosecuted Patent Application DE 34 06 424 A1 (Später), dated February 7, 1985;

German Examination Report, dated December 11, 2002.

The above-mentioned references were cited in an Information Disclosure Statement submitted on January 27, 2003, in parent application No. 09/520,279.

United States Patent No. 5,359,447 (Hahn et al.), dated October 25, 1994, and corresponding Japanese Patent Application JP7 170 231, dated July 4, 1995;

United States Patent No. 5,434,939 (Matsuda), dated July 18, 1995, and corresponding Japanese Patent Application JP 6 237 016, dated August 23, 1994;

Japanese Patent Application JP 4 363 081 (Mori et al.), dated December 15, 1992, which corresponds with U.S. Patent No. 5,181,219, dated January 19, 1993, United States Patent No. 5,181,221, dated January 19, 1993, United States Patent No. 5,182,757, dated January 26, 1993, United States Patent No. 5,295,148, dated March 15, 1994, United States Patent No. 5,317,584, dated May 31, 1994, United States Patent No. 5,356,832, dated October 18, 1994, United States Patent No. 5,404,369, dated April 4, 1995, United States Patent No. 5,436,922, dated July 25, 1995, United States Patent No. 5,537,666, dated July 16, 1996, and United States Patent No. 5,587,335, dated December 24, 1996;

Japanese Patent Application JP 8 340 156 (Kondo et al.), dated December 24, 1996, and English abstract thereof;

Japanese Patent Application JP 11 014 869 (Yamaguchi et al.), dated January 22, 1999, and English abstract thereof;

Japanese Office Action dated September 19, 2003.

The above-mentioned references were cited in an Information Disclosure Statement submitted on December 12, 2003, in parent application No. 09/520,279.

U.S. Patent No. 5,790,310 (Huang), dated August 1998;

U.S. Patent No. 4,743,091 (Gelbart), dated May 1988;

U.S. Patent No. 6,356,574 (Craig et al.), dated March 2002;

U.S. Patent No. 3,981,590 (Perkins), dated September 1976;

The above-mentioned references were cited in an Office Action dated February 26, 2003, in parent application No. 09/520,279.

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant. As per the Notice in 1273 OG 55 (August 5, 2003) no copies of any above-mentioned U.S. patents and U.S. patent application publications are submitted for any application filed after June 30, 2003.

LAURENCE A. GREENBERG REG. NO. 29,308

Respectfully submitted,

Fer Applicant

Date: March 26, 2004

Lerner and Greenberg, P.A. Post Office Box 2480

Hollywood, FL 33022-2480

Tel: (954) 925-1100 Fax: (954) 925-1101

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	Α	6,044,188	03/28/00	Kropp `						
	В	6,353,491 B1	03/05/02	Tanaka et al.						
	С	5,359,447	10/25/94	Hahn et al.						
	D	5,434,939	07/18/95	Matsuda						
	E	5,181,219	01/19/93	Mori et al.						
	F	5,181,221	01/19/93	Mori et al.						
	G	5,182,757	01/26/93	Mori et al.						
	Н	5,295,148	03/15/94	Mori et al.						
	ī	5,317,584	05/31/94	Mori et al.	1					
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	J	196 45 295 A1	04/30/98	Germany						
	K	198 38 571 A1	03/04/99	Germany						
	L	29 30 317 C2	02/19/81	Germany						
	M	31 12 167 A1	10/14/82	Germany						
	N	34 06 424 A1	02/07/85	Germany						
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<del></del>		P.L. Gourley et al.: "Coherent beams from high efficiency two-dimensional surface-emitting semiconductor laser arrays", Appl. Phys. Lett., Vol. 58, No. 9, March 4, 1991, pp. 890-892								
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	Α	5,356,832	10/18/94	Mori et al.				
	В	5,404,369	04/04/95	Mori et al.				
	С	5,436,922	07/25/95	Mori et al.				
	D	5,537,666	07/16/96	Mori et al.				
	E	5,587,335	12/24/96	Mori et al.				
	F	5,790,310	8/98	Huang				
	G	4,743,091	5/88	Gelbart				
	Н	6,356,574	3/02	Craig				
	ī	3,981,590	9/76	Perkins			1	
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	N	11 014 869	01/22/99	Japan				
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